

STK800

N-channel 30V - 0.006Ω - 20A - PolarPAK[®] STripFET™ Power MOSFET

Features

Туре	V_{DSS}	R _{DS(on)}	R _{DS(on)} *Q _g	P _{TOT}
STK800	30V	<0.0078Ω	100.5nC*mΩ	5.2W

- Ultra low top and bottom junction to case thermal resistance
- Very low capacitances
- 100% Rg tested
- Fully encapsulated die
- 100% Matte tin finish (in compliance with the 2002/95/EC european directive)
- PolarPAK[®] is a trademark of VISHAY

Application

Switching applications

Description

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low onresistance, moreover the double sides cooling package with ultra low junction to case thermal resistance allows to handle higher levels of current.

Order code	Marking	Package	Packaging
STK800	K800	PolarPAK [®]	Tape & reel

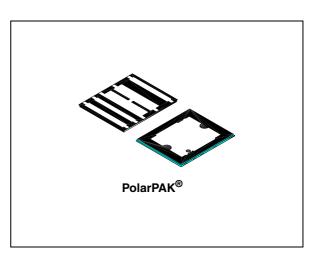
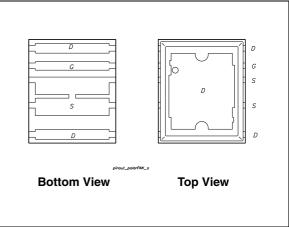


Figure 1. Internal schematic diagram



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1 Electrical ratings

Table 2.	Absolute	maximum	ratings
	Absolute	maximum	raungs

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{GS} ⁽¹⁾	Gate-source voltage	± 16	V
V _{GS} ⁽²⁾	Gate-source voltage	± 18	V
I _D ⁽⁴⁾	Drain current (continuous) at $T_C = 25^{\circ}C$	20	Α
I _D	Drain current (continuous) at T _C = 100°C	12.5	Α
I _{DM} ⁽³⁾	Drain current (pulsed)	80	А
P _{TOT} ⁽⁴⁾	Total dissipation at $T_{C} = 25^{\circ}C$	5.2	W
	Derating factor	0.0416	W/°C
E _{AS} ⁽⁵⁾	Single pulse avalanche energy	1	J
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

1. Continuous mode

2. Guaranteed for test time ≤ 15 ms

3. Pulse width limited by package

4. When mounted on FR-4 board of 1inch², 2 oz Cu and \leq 10sec

5. Starting $T_J = 25^{\circ}C$, $I_D = 10A$, $V_{DD} = 25V$

	Table 3.	Thermal data
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Symbol	Parameter	Тур.	Max.	Unit
Rthj-amb ⁽¹⁾	Thermal resistance junction-amb	20	24	°C/W
Rthj-c ⁽²⁾	Thermal resistance junction-case (top drain)	1	1.2	°C/W
Rthj-c ⁽³⁾	Thermal resistance junction-case (source)	2.8	3.4	°C/W

1. When mounted on FR-4 board of 1inch², 2 oz Cu and \leq 10sec

2. Steady state

3. Measured at source pin when the device is mounted on FR-4 board in steady state



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = Max rating, V _{DS} = Max rating,Tc=125°C			1 10	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{GS} = \pm 16V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		2.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 10A V _{GS} = 4.5V, I _D = 10A		0.006 0.0075	0.0078 0.0098	Ω Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		1380 450 75		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} =15V, I_D = 20A V_{GS} =4.5V (see Figure 16)		13.4 3.4 4.5		nC nC nC
Q _{gs1} Q _{gs2}	Pre V _{th} gate-to-source charge Post V _{th} gate-to-source charge	V_{DD} =15V, I_D = 12A V_{GS} =4.5V (see Figure 21)		1 2.4		nC nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20mV open drain		1		Ω



	e interning times					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD}=15V, I_{D}=10A,$ $R_{G}=4.7\Omega, V_{GS}=4.5V$ (see Figure 15)		15 50		ns ns
t _{d(off)} t _f	Turn-off delay time Fall time	V_{DD} =15V, I _D = 10A, R _G =4.7 Ω , V _{GS} =4.5V (see Figure 15)		45 15		ns ns

Table 6. Switching times

 Table 7.
 Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				20 80	A A
V _{SD} ⁽²⁾	Forward on Voltage	I _{SD} = 20A, V _{GS} =0			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 20A, di/dt = 100A/μs, V _{DD} =20V, Tj=150°C (<i>see Figure 20</i>)		32 28.8 1.8		ns nC A

1. Pulse width limited by package

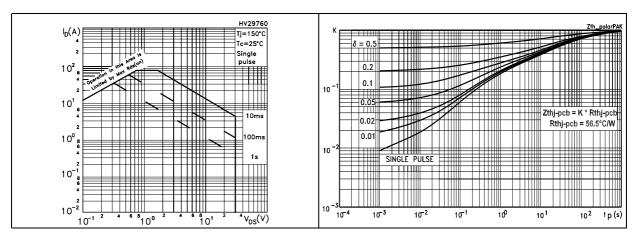
2. Pulsed: pulse duration = $300\mu s$, duty cycle 1.5%

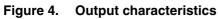
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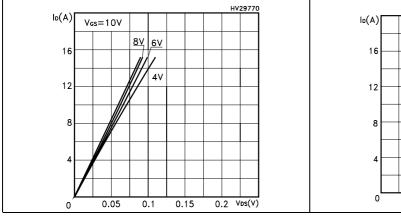
2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

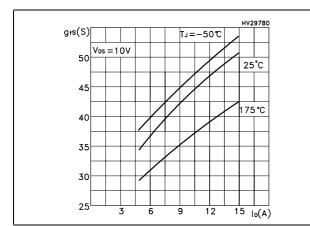














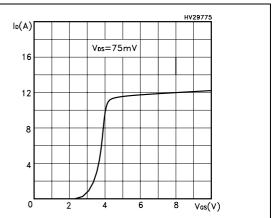
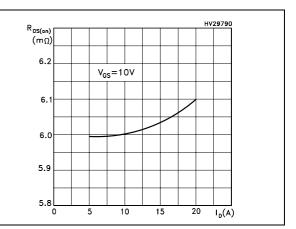


Figure 7. Static drain-source on resistance



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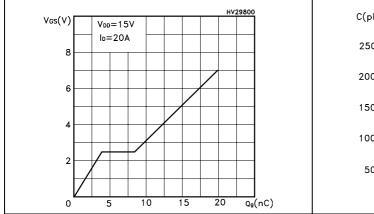


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs temperature

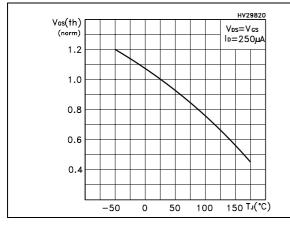
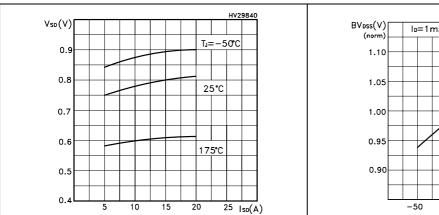


Figure 12. Source-drain diode forward characteristics



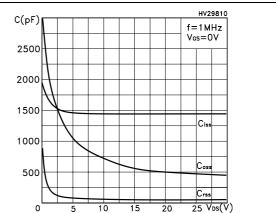


Figure 11. Normalized on resistance vs temperature

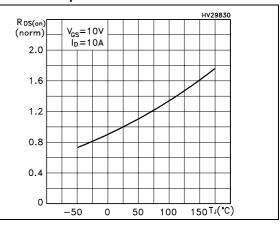
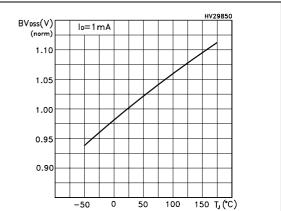
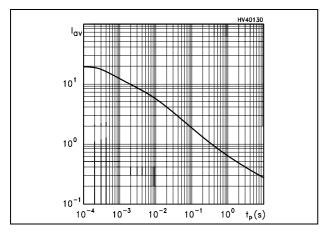


Figure 13. Normalized B_{VDSS} vs temperature



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Figure 14. Allowable I_{AV} vs time in avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

 $P_{D(AVE)} = 0.5*(1.3*B_{VDSS}*I_{AV})$

E_{AS(AR)}=P_{D(AVE)} *t_{AV}

Where:

 I_{AV} is the allowable current in avalanche

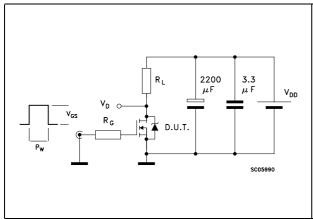
 $P_{D(AVE)}$ is the average power dissipation in avalanche (single pulse)

 $t_{\mbox{\scriptsize AV}}$ is the time in avalanche



3 Test circuit

Figure 15. Switching times test circuit for resistive load



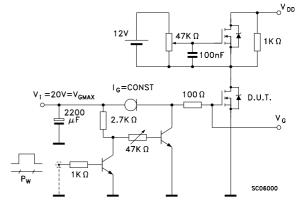
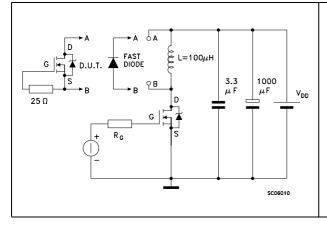
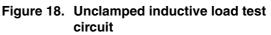


Figure 17. Test circuit for inductive load switching and diode recovery times







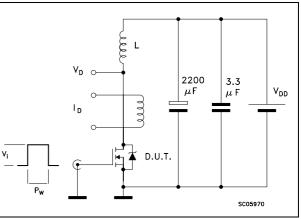


Figure 20. Switching time waveform

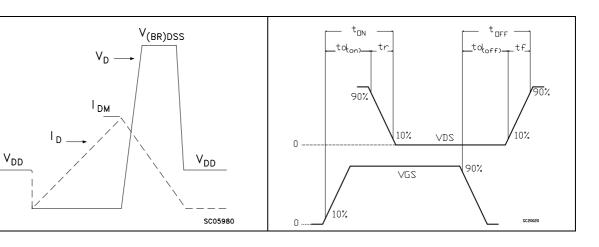
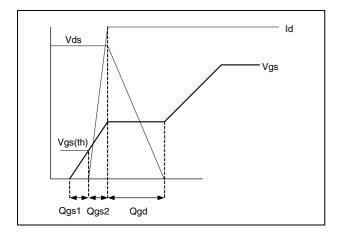


Figure 16. Gate charge test circuit



Figure 21. Gate charge waveform





4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*



Table 8.	FUIAIFAN) mechanica	Tuala			
Ref.	mm				inch		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
А	0.75	0.80	0.85	0.030	0.031	0.033	
A1			0.05			0.002	
b1	0.48	0.58	0.68	0.019	0.023	0.027	
b2	0.41	0.51	0.61	0.016	0.020	0.024	
b3	2.19	2.29	2.39	0.086	0.090	0.094	
b4	0.89	1.04	1.19	0.035	0.041	0.047	
b5	0.23	0.33	0.43	0.009	0.013	0.017	
с	0.20	0.25	0.30	0.008	0.010	0.012	
D	6	6.15	6.30	0.236	0.242	0.248	
D1	5.74	5.89	6.04	0.226	0.232	0.238	
E	5.01	5.16	5.31	0.197	0.203	0.209	
E1	4.75	4.90	5.05	0.187	0.193	0.199	
H1	0.23			0.009			
H2	0.45		0.56	0.018		0.022	
H3	0.31	0.41	0.51	0.012	0.016	0.020	
H4	0.45		0.56	0.018		0.022	
11	1.92	1.97	2.02	0.075	0.077	0.079	
J1	0.38	0.43	0.48	0.014	0.016	0.018	
K1	4.22	4.37	4.52	0.166	0.172	0.178	
K4	0.24			0.009			
M1	4.30	4.50	4.70	0.169	0.177	0.185	
M2	3.43	3.58	3.73	0.135	0.141	0.147	
M3	0.22			0.009			
M4	0.05			0.002			
P1	0.15	0.20	0.25	0.006	0.008	0.010	
T1	3.48	3.64	4.10	0.137	0.143	0.161	
T2	0.56	0.76	0.95	0.022	0.030	0.037	
Т3	1.20			0.047			
T4	3.90			0.154			
T5		0.18	0.36		0.007	0.014	
<	0°	10°	12°	0°	10°	12°	

 Table 8.
 PolarPAK[®] (option "S") mechanical data



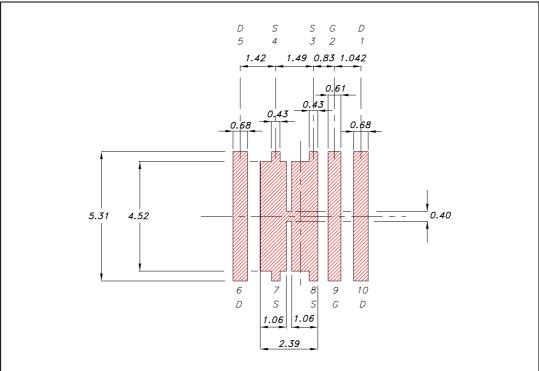


М4 -M4 10 D 9 G 8 \$ Ь 51.5 Φŧ Ĕ 12 View A Ě Ė M2 -13--M1 \bigcirc 15 I S 3 G 2 D 1 S 4 D 5 (Top View) 6.15 Ζ (\square) 0.41 0.51 0.51 0.58 0.38 2.29 0.38 b 0.39 6 D 10 D 9 G 7 S 8 S lπ $\overline{\mathbf{A}}$ P1-+ 1.37 (Bottom View) P1--b4-₹ T Ш) P D 1 0.39 Ģ 0.33 b5 5 0.69 0.83 1.042 1.42 1.49

Figure 22. PolarPAK[®] (option "S") drawings









5 Revision history

Table 9. Document revision history

Date Revision		Changes		
10-Nov-2005	1	First version		
02-Feb-2006	2	Complete version		
21-Mar-2006	3	The document has been reformatted		
25-May-2006	4	New note on page 1		
14-Nov-2006	5	Modified : Features		
14-May-2007	6	New data on Table 5 and new Figure 21		
11-Jun-2007	7	Updated Figure 2, Figure 3		
03-Sep-2007	8	Updated mechancal data		
05-Oct-2007	9	Inserted new Figure 23: Recommended PAD layout		



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